Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/038,125	CHOE, GEON
Examiner	Art Unit
Angel A. Castro	2653

	SEARCHED					
Class	Subclass	Date	Examiner			
360	324.1, 324.11					
	324.1L					
29	(03.07, 603.0					
	603.13-603.16					
	603.18	6/23/05	AC			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST U.S. Pat	. ,			
EPO, JPO	6/23/25	Ac		
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